Application/Control No. Applicant(s)/Patent Under Reexamination 10/755,390 HAN ET AL Notice of References Cited Examiner Art Unit Page 1 of 1 Nguyen N Hanh 2834 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-4,761,602 08-1988 Leibovich, Gregory 318/816 Α US-6,525,442 02-2003 В Koharagi et al. 310/156.48 09-1984 US-4,469,970 Neumann, Thomas W. С 310/158.78 US-6,269,290 07-2001 Egami et al. D 701/22 Ε US-US-F US-G US-Н US-US-J US-K US-US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Classification Country Name MM-YYYY DE3609351 09-1987 GERMAN Ν Henneberger et al. H02K 18/04 0 P Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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